

## Metal Composite Power Inductor (Thin Film) Specification Sheet



#### CIGT252012LM1R0MNE (2520 / EIA 1008)

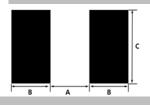
#### APPLICATION

Smart phones, Tablet, Wearable devices, Power converter modules, etc.

#### FFATURES

Small power inductor for mobile devices
Low DCR structure and high efficiency inductor for power circuits.
Monolithic structure for high reliability
Free of all RoHS-regulated substances
Halogen free

#### RECOMMENDED LAND PATTERN



	Unit : mm
TYPE	2520
Α	1.2
В	0.8
С	2.0

#### DIMENSION



TYPE	Dimension [mm]						
III	L	T	D				
2520	2.5±0.2	2.0±0.2	1.2 max	0.55±0.25			

#### DESCRIPTION

Part no.	Size	Thickness	Inductance	Inductance tolerance	DC Resistance [mΩ] Rat		DC Resistance [mΩ] Rated DC Current (Isat)		Rated DC C	( -,
Part no.	[inch/mm] [mm] (max)	[uH]	(%)	Max.	Тур.	Max.	Тур.	Max.	Тур.	
CIGT252012LM1R0MNE	1008/2520	1.2	1.0	±20	40	34	3.8	4.5	3.4	3.8

- \* Inductance : Measured with a LCR meter 4991A(Agilent) or equivalent (Test Freq. 1MHz, Level 0.1V)
- \* DC Resistance : Measured with a Resistance HI-TESTER 3541(HIOKI) or equivalent
- \* Maximum allowable DC current : Value defined when DC current flows and the initial value of inductance has decreased by 30% or when current flows and temperature has risen to 40 °C whichever is smaller. (Reference: ambient temperature is 25 °C±10)

(Isat): Allowable current in DC saturation: The DC saturation allowable current value is specified when the decrease of

(Irms) : Allowable current of temperature rise : The temperature rise allowable current value is specified when temperature of the inductor is raised 40 ℃ by DC current. (Reference: ambient temperature is 25 ℃±10)

- $^{\star}$  Absolute maximum voltage : Absolute maximum voltage DC 20V.
- $^{\star}$  Operating temperature range : -40 to +125  $^{\circ}\text{C}$  (Including self-temperature rise)

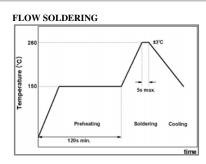
#### PRODUCT IDENTIFICATION

<u>CIG</u>	<u>T</u>	<u>2520</u>	<u>12</u>	<u>LM</u>	<u>1R0</u>	<u>M</u>	<u>N</u>	<u>E</u>
(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)	(9)

- (1) Power Inductor
- (3) Dimensior (2520: 2.5mm × 2.0mm )
- (5) Remark (Characterization Code)
- (7) Toleranc (M:±20%)
- (8) Internal Code
- (9) Packaging (C:paper tape, E:embossed tape)
- (2) Type (T: Metal Composite Thin Film Type)
- (4) Thicknes (12: 1.2mm)
- (6) Inductan (1R0: 1.0 uH)

#### RECOMMENDED SOLDERING CONDITION

# REFLOW SOLDERING 280 230 230 100 max. Preheating Soldering Cooling 30 - 60s max.



IRON SOLDERING	
Temperature of	280 ℃ max.
Soldering Iron Tip	200 Ciliax.
Preheating	150℃min.
Temperature	130 C min.
Temperature	ΔT≤130℃
Differential	$\Delta 1 \ge 130 \text{ C}$
Soldering Time	3sec max.
Wattage	50W max.

#### **PACKAGING**

Packaging Style	Quantity(pcs/reel)
Embossed Taping	2500 pcs

Item	Specified Value	Т	est Condition		
Solderability	More than 90% of terminal electrode should be soldered newly.		for 4±1 seconds, and preheated at the specimen shall be immersed in seconds.		
Resistance to Soldering	No mechanical damage. Remaining terminal Electrode: 75% min. Inductance change to be within ±20% to the initial.		for 4±1 seconds, and preheated at , the specimen shall be immersed in ±0.5 seconds.		
Thermal Shock (Temperature Cycle test)	No mechanical damage Inductance change to be within ±20% to the initial.	Repeat 100 cycles under the following conditions40 $\pm 3$ °C for 30 min $\rightarrow$ 85 $\pm 3$ °C for 30 min			
High Temp. Humidity Resistance Test	No mechanical damage Inductance change to be within ±20% to the initial	85±2°C, 85%RH, for 500: Measure the test items at and humidity for 24 hours	ter leaving at normal temperature		
Low Temperature Test	No mechanical damage Inductance change to be within ±20% to the initial.	Solder the sample on PC at -55±2°C for 500±12 ho Measure the test items at and humidity for 24hours.	urs. ter leaving at normal temperature		
High Temperature Test	No mechanical damage Inductance change to be within ±20% to the initial.	hours.	B. Exposure at 125±2°C for 500±12 ter leaving at normal temperature		
High Temp. Humidity Resistance Loading Test	No mechanical damage Inductance change to be within ±20% to the initial	85±2°C, 85%RH, Rated C Measure the test items at and humidity for 24 hours	ter leaving at normal temperature		
High Temperature Loading Test	No mechanical damage Inductance change to be within ±20% to the initial		ated Current for 500±12 hours. he test items after leaving at normal temperature lity for 24 hours.		
Reflow Test	No mechanical damage Inductance change to be within ±20% to the initial				
Vibration Test	No mechanical damage Solder the sample on PCB. Vibrate as apply 10~55H. amplitude for 2 hours in each of three(X,Y,Z) axis (tot hours).				
	No mechanical damage	Bending Limit; 2mm Test Speed; 1.0mm/sec. Keep the test board at the PCB thickness: 1.6mm	e limit point in 5 sec.		
Bending Test	46	20 R340	Unit :mm 2		
	No indication of peeling shall occur on the	W(kgf)	TIME(sec)		
	terminal electrode.	0.5	10±1		
Terminal Adhesion Test		<b>W</b> W			
Drop Test	No mechanical damage Inductance change to be within ±20% to the initial.	Random Free Fall test on 1 meter, 10 drops	concrete plate.		
lpeak (AC+DC Load Life)	Initial.  No mechanical damage Inductance change to be within ±20% to the initial  85±2°C, 85%RH, Load(Ipeak) for 120 hours.  (Frequncy:1MHz, Load(Ipeak):1.5hr on / 0.5hr Measure the test items after leaving at normal and humidity for 24 hours.  * Load(Ipeak) = Irms(max)×1.4				



## Metal Composite Power Inductor (Thin Film) Data Sheet

### RoHS-Halogen Compliant

#### 1. Model: CIGT252012LM1R0MNE

#### 2. Description

Part no. Size [inch/mm]				Inductance tolerance (%)	DC Resistance [mΩ]		Rated DC Current (Isat) [A]		Rated DC Current (Irms) [A]	
	[inch/mm] [mm] (max)	[uH]	Max.		Тур.	Max.	Тур.	Max.	Тур.	
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(Isat) : Allowable current in DC saturation : The DC saturation allowable current value is specified when the decrease of the initial inductance value at 30% (Reference: ambient temperature is 25 °C±10)

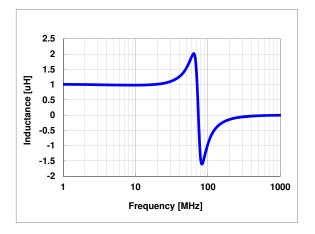
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- \* Absolute maximum voltage : Absolute maximum voltage DC 20V.
- \* Operating temperature range : -40 to +125°C (Including self-temperature rise)

#### 3. Characteristics data

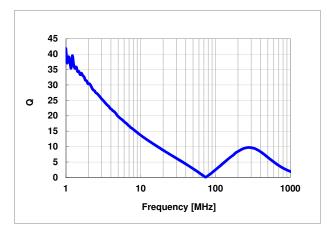
#### 1) Frequency characteristics (Ls)

Agilent E4294A +E4991A , 1MHz to 1,000MHz

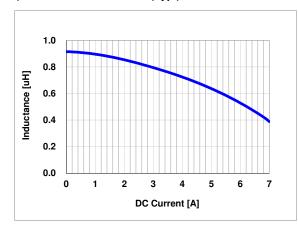


#### 2) Frequency characteristics (Q)

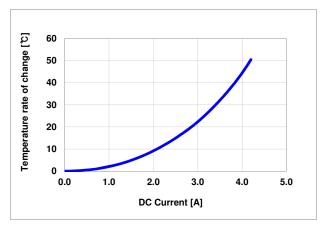
Agilent E4294A +E4991A , 1MHz to 1,000MHz



#### 3) DC Bias characteristics (Typ.)



#### 4)Temperature characteristics (Typ.)





Any data in this sheet are subject to change, modify or discontinue without notice The data sheets include the typical data for design reference only. If there is any question regarding the data sheets, please contact our sales personnel or application engineers